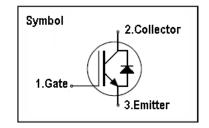


### **IGBT**

### **Features**

- 1200V,25A 内绝缘
- $V_{CE(sat)(typ.)}$ =2.2V@ $V_{GE}$ =15V, $I_{C}$ =25A
- High speed switching
- Higher system efficiency
- Soft current turn-off waveforms
- Square RBSOA using NPT technology



# **General Description**

JIAEN NPT IGBTs offer lower losses and higher energy efficiency for application such as IH (induction heating), UPS, general inverter and other soft switching applications.

# **Absolute Maximum Ratings**

Symbol	Parameter	Value	Units
Vces	Collector-Emitter Voltage	1200	V
V <sub>GES</sub>	Gate-Emitter Voltage	<u>+</u> 30	V
1-	Continuous Collector Current (T <sub>C</sub> =25 °C)	45	А
lc	Continuous Collector Current (Tc=100°C)	25	А
Ісм	Pulsed Collector Current (Note 1)	80	Α
l <sub>F</sub>	Diode Continuous Forward Current (T <sub>C</sub> =100 °C)	25	Α
I <sub>FM</sub>	Diode Maximum Forward Current (Note 1)	60	А
tsc	Short Circuit Withstand Time VGE=15V, Vcc≤960V, Tj≤150°C	10	us
D-	Maximum Power Dissipation (T <sub>C</sub> =25 °C)	210	W
P <sub>D</sub>	Maximum Power Dissipation (Tc=100°C)	100	W
TJ	Operating Junction Temperature Range	-55 to +150	$^{\circ}$
T <sub>STG</sub>	Storage Temperature Range	-55 to +150	$^{\circ}$

# **Thermal Characteristics**

Symbol	Parameter	Max.	Units
R <sub>th j-c</sub>	Thermal Resistance, Junction to case for IGBT	0.48	°C/ W
R <sub>th j-c</sub>	Thermal Resistance, Junction to case for Diode	0.87	°C/ W
R <sub>th j-a</sub>	Thermal Resistance, Junction to Ambient	40	°C/ W



# **Electrical Characteristics** (Tc=25°C unless otherwise noted )

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
BV <sub>CES</sub>	Collector-Emitter Breakdown Voltage	$V_{GE} = 0V, I_{C} = 250uA$	1200	-	-	V
I <sub>CES</sub>	Collector-Emitter Leakage Current	V <sub>CE</sub> = 1200V, V <sub>GE</sub> = 0V	-	-	250	uA
1	Gate Leakage Current, Forward	$V_{GE}$ =30V, $V_{CE}$ = 0V	-	-	100	nA
I <sub>GES</sub>	Gate Leakage Current, Reverse	$V_{GE}$ = -30V, $V_{CE}$ = 0V	-	-	-100	nA
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE} = V_{CE}$ , $I_C = 250uA$	4.5	-5.0	5.5	V
		V <sub>GE</sub> =15V, I <sub>C</sub> = 25A	-			
\/	Collector Emitter Seturation Valtage	Tc=25°C		2.2	2.6	V
V <sub>CE(sat)</sub>	Collector-Emitter Saturation Voltage	T <sub>C</sub> =125°C		2.7		
		Tc=150°C		3.0		
Qg	Total Gate Charge	Vcc=960V	-	130		nC
Q <sub>ge</sub>	Gate-Emitter Charge	V <sub>GE</sub> =15V	-	30		nC
Qgc	Gate-Collector Charge	I <sub>C</sub> =25A	-	70		nC
t <sub>d(on)</sub>	Turn-on Delay Time		-	22	-	ns
t r	Turn-on Rise Time	Vcc=600V	-	35	-	ns
t d(off)	Turn-off Delay Time	V <sub>GE</sub> =15V	-	290	-	ns
t f	Turn-off Fall Time	Ic=25A R <sub>G</sub> =10Ω	-	170	-	ns
Eon	Turn-on Switching Loss	Inductive Load	-	2.2	-	mJ
Eoff	Turn-off Switching Loss	Tc=25 ℃	-	1.4	-	mJ
Ets	Total Switching Loss		-	3.6	-	mJ
C <sub>ies</sub>	Input Capacitance	V <sub>CE</sub> =25V	-	1250	-	pF
Coes	Output Capacitance	V <sub>GE</sub> =0V	-	210	-	pF
C <sub>res</sub>	Reverse Transfer Capacitance	f = 1MHz	-	150	-	pF
RGint	Integrated gate resistor			3.8		Ω

# Electrical Characteristics of Diode (Tc=25°C unless otherwise noted)

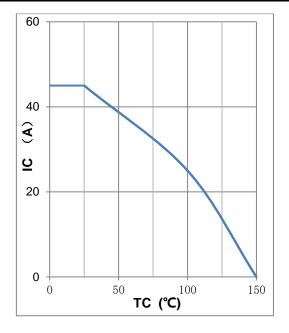
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
V <sub>F</sub>	Diode Forward Voltage	I <sub>F</sub> =25A	1	2.3	2.5	V
trr	Diode Reverse Recovery Time	V <sub>CE</sub> = 600V	•	190		ns
Irr	Diode peak Reverse Recovery Current	I <sub>F</sub> = 25A	1	20		Α
Qrr	Diode Reverse Recovery Charge	$dI_F/dt = 500A/us$	-	1600		nC

#### Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature



# **Typical Performance Characteristics**



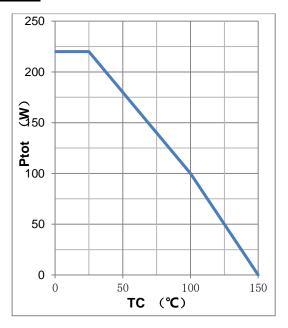
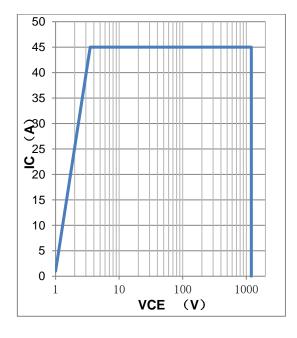


Figure1:maximum DC collector current VS. case temprature

Figure2:power dissipation VS. case temprature





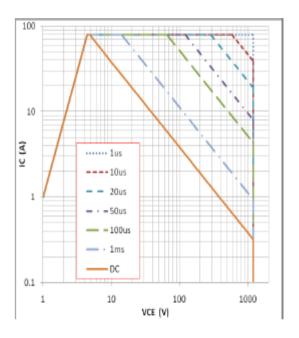


Figure4:forward SOA,TC=25  $^{\circ}$ C,TJ $\leqslant$ 150  $^{\circ}$ C





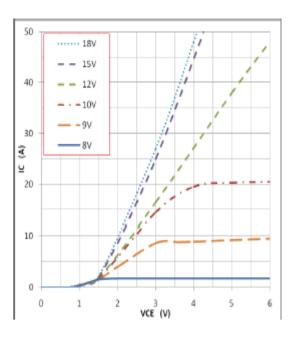


Figure 5: typical IGBT output characteristics,  $\label{eq:typical} TJ = 25\,^{\circ}\mathrm{C}\,; tp = 300us$ 

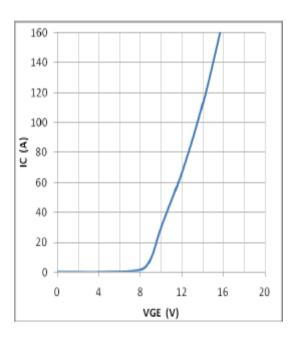


Figure6:typical trans characteristics, VCE=20V,tp=20us

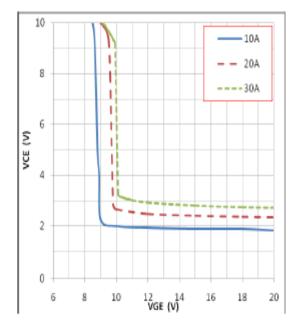


Figure7: typical VCE VS. VGE,TJ=25°C

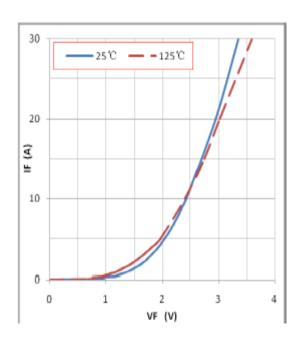


Figure8:typical diode forward characteristic,tp=300us



## JNG25N120AI

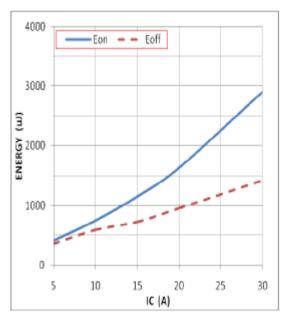


Figure9: typical energy loss VS. IC, TC=25°C,

L=500uH, VCE=600V,VGE=15V,Rg= $28\Omega$ 

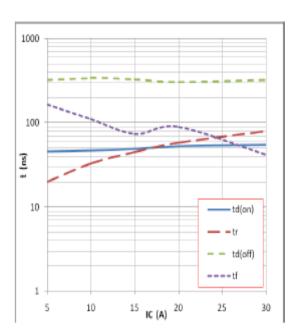


Figure 10: typical switching time VS. IC, TC=25°C,

L=500uH, VCE=600V,VGE=15V,Rg= $28\Omega$ 

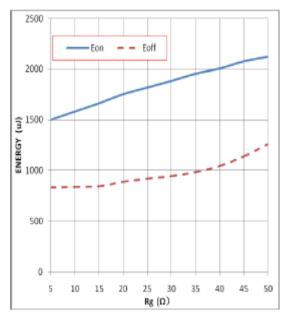


Figure11: typical energy loss VS. Rg,TC=25°C,

L=500uH, VCE=600V, VGE=15V,IC=25A

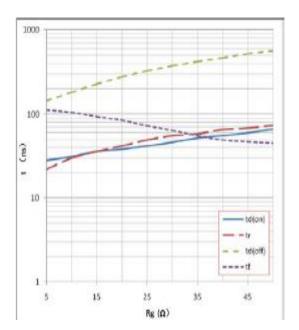


Figure 12: typical switching time VS. Rg, TC=25°C,

L=500uH,VCE=600V,VGE=15V,IC=25A



# JNG25N120AI

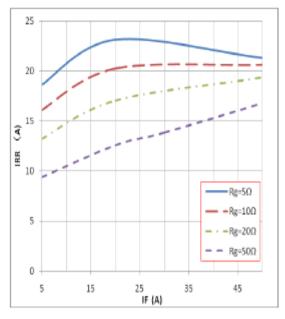


Figure13: typical diode IRR VS. IF, TC=25°C

VCC=600V, VGE=15V

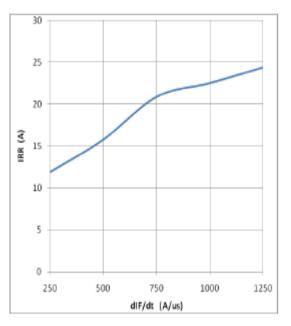


Figure14:typical diode IRR VS. dIF/dt

VCC=600V,VGE=15V

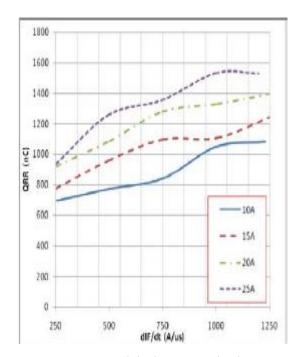
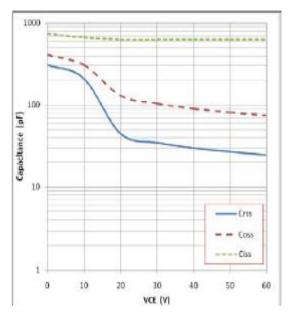


Figure15:typical diode QRR VS. dIF/dt

VCC=600V,VGE=15V







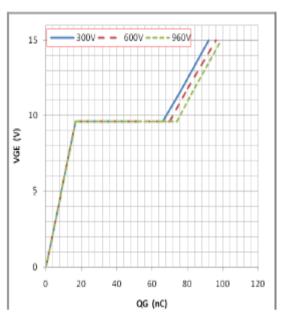
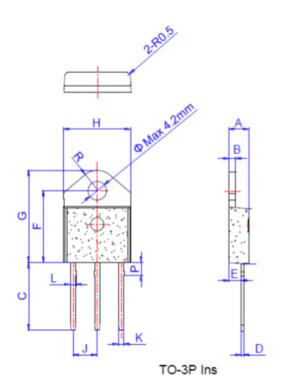


Figure17:typical capacitance VS. VCE,VGE=0V,f=100kHz

Figure 18: typical gate charge VS. VGE, IC=25A

### **TO-3P PACKAGE OUTLINE**



	Dimensions					
Ref.	Millimeters			Inches		
	Min.	Тур.	Max.	Min.	Тур.	Max.
Α	4.40		4.60	0.173		0.181
В	1.45		1.55	0.057		0.061
С	14.35		15.60	0.565		0.614
D	0.50		0.70	0.020		0.028
Е	2.70		2.90	0.106		0.114
F	15.80		16.50	0.622		0.650
G	20.40		21.10	0.803		0.831
Н	15.10		15.50	0.594		0.610
J	5.40		5.65	0.213		0.222
K	1.10		1.40	0.043		0.055
L	1.35		1.50	0.053		0.059
Р	2.80		3.00	0.110		0.118
R		4.35			0.171	





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